



Sheet 1 of 1

LIST OF ART CITED BY APPLICANT

(Use several sheets if necessary)

Atty Docket No.	Serial No.
A01511	10/812,127
Applicant	Heer et al.
Filing Date	Group
3/29/04	1614

U.S. Patent Documents

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	Class/Subclass	FILING DATE IF APPROPRIATE
AA					
AB					
AC					
AD					
AE					
AF					
AG					
AH					
AI					
AJ					
AK					

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	Class/Subclass	Translation Yes/No
RTN	AL WO 98/33380	8/6/98	WO		
AM					
AN					
AO					
AP					

OTHER ART (Including Author, Title, Date, Pertinent Patents, etc.)

AR	
AS	
AT	

Examiner

Date Considered

7/27/05

*EXAMINER: Initial reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not conformance and not considered. Include copy of this form with next communication to applicant.



Sheet 1 of 1

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Atty Docket No. A01511	Serial No. 10/812,127
Applicant Heer et al.	
Filing Date March 29, 2004	Group 1614

U.S. Patent Documents

EXAMINER INITIALS		DOCUMENT NUMBER	DATE	NAME	Class/Subclass	FILING DATE IF APPROPRIATE
<i>ZON</i>	AA	5,939,203	8/17/99	Kappock et al.		
<i>ZIN</i>	AB	10/812,040	3/29/04	Heer et al.		
<i>ZON</i>	AC	10/811,518	3/29/04	Heer et al.		
	AD					
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	AG					
	AH					
	AI					
	AJ					
	AK					

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	Class/Subclass	Translation Yes/No
<i>ZON</i>	AL	0 979 033B1	1/15/03	EP		
	AM					
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U.S. Patent Documents

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS/SUBCLASS	FILING DATE IF APPROPRIATE
RTN	AA 4,012,503	3/15/77	Freiman		
	AB				
	AC				
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	AG				
	AH				
	AI				

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS/SUBCLASS	TRANSLATION YES/NO
RTN	AJ 1,389,424	4/8/03	EP		
RTN	AK 2002 284612	10/03/02	JP		Abstract
RTN	AL 2000 103709	4/11/00	JP		Abstract
RTN	AM 96/23850	8/8/96	WO		
RTN	AN 98/36904	8/27/98	WO		
RTN	AO 00/59305	10/12/00	WO		
	AP				

OTHER ART (Including Author, Title, Date, Pertinent Patents, etc.)

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Examiner *Heer et al.* Date Considered

8/05/05

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